## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10531397	KLOSTERS ET AL.
Examiner	Art Unit
Flores, Leon	2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	354, 368	11/30/2007	LF		
370	509, 510	11/30/2007	LF		
327	141	11/30/2007	LF		

SEARCH NOTES			
Search Notes	Date	Examiner	
Consulted with SPE David Payne in regards to the patentability of the claims.	12/11/2007	LF	
Checked for possible double patenting.	11/29/2007	LF	
Searched in EAST & NPL (IEEE).	11/30/2007	LF	
Consulted with SPE David Payne in regards to the references used to reject the claims.	7/11/2008	LF	
Consulted with SPE David Payne in regards to the arguments.	12/19/2008	LF	
Consulted wtih SPE David Payne in regards to the patentability of the claims.	9/9/2009	LF	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
375	354, 368	9/10/2009	LF	
455	502	9/10/2009	LF	
327	141	9/10/2009	LF	
370	509-510	9/10/2009	LF	

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